



**SOPHISTICATED ANALYTICAL INSTRUMENTATION FACILITY (SAIF)  
AND  
CENTRAL INSTRUMENTATION LABORATORY (CIL)  
PANJAB UNIVERSITY**

**Chandigarh-160 014 (INDIA)**

(Est. under the Panjab University Act VII of 1947 enacted by the Govt. of India)

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The **SAIF/CIL** facility of **Panjab University** is organizing a three day workshop on *X-Ray Techniques for Characterization of Materials*, “**XRCM-2015**”. This workshop is designed to impart theoretical knowledge and basics of instrumentation coupled with Hands-on-training sessions on the running of XRD and XRF.

**Venue:** Department of SAIF/CIL, Panjab University, Chandigarh.

**Date of Workshop:** February 11- 13, 2015

**Registration Fee:** Participation will be through advance registration by submission of the prescribed registration form accompanied with a fee of **Rs 3000/-** on or before the due date. Registration fee includes a Registration kit, Lunch and morning & evening tea, everyday to the participants. Demand draft for registration fee should be drawn in favor of “Director CIL, Chandigarh” payable at Chandigarh.

**Accommodation:** Limited accommodation at Panjab University hostels and guest house is available at nominal charges. Those who are interested may contact the undersigned.

**Date for Early- Bird Registration:** 20<sup>th</sup> January 2015

*Registration @Rs.5000/- will be available from January 20-31, 2015.*

***How to apply***

**Step 1:** Fill the attached **registration form**.

**Step 2:** Demand draft for **Rs.3000/-** (per participant) drawn in favor of “Director CIL, Chandigarh” payable at Chandigarh.

**Step 3:** Send by email a scanned advance copy of the demand draft and registration form at email id [xrcm2015@gmail.com](mailto:xrcm2015@gmail.com)

**Step 4:** Send the Demand Draft through courier or speed post along with filled registration form so as to reach the following address on or before **Jan 20<sup>th</sup>, 2015**.

***Address:***

The Director ,  
Department of CIL,  
Panjab University, Sector 14, Chandigarh-160-014.

***Contact us:***

1. Mr. H.P.S.Kang,  
Department of CIL/SAIF,  
Panjab University,  
Chandigarh-14.  
Ph.no: 0172-2534055

2. Mr. Ramesh Sharma,  
Department of CIL/SAIF,  
Panjab University,  
Chandigarh-14.  
Ph.no:+91-9815604963

Email:[xrcm2015@gmail.com](mailto:xrcm2015@gmail.com)

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**REGISTRATION FORM**

**FOR**

*X-Ray Techniques for Characterization of Materials “XRCM-2015”*

**February 11 to 13, 2015**

Name (Capital letters)

:

Gender

:

Male ☐ Female ☐

Designation

:

Qualification

:

Institution /Organization

:

Postal Address

:

Pin code

:

Phone no

:

E-mail

:

Do you need accommodation? : Yes/No ☐ Days ☐ No of Persons ☐

Mode of registration : Demand draft / Spot registration (Please tick)

Demand draft no

:

Date:

Bank details

:

Full signature with date

(\*Scanned Copy of Registration form & acknowledgement of transaction details  
should be sent to [xrcm2015@gmail.com](mailto:xrcm2015@gmail.com))